

## TITLE OF THE INVENTION

### Current Mirror Circuit and Current Source Circuit

## CROSS REFERENCE TO RELATED APPLICATIONS

5 This application claims benefit of priority under 35 USC 119 based on Japanese patent application P10-338008, filed November 27, 1998, the entire contents of which are incorporated by reference herein.

## BACKGROUND OF THE INVENTION

### 1. Field of the Invention

10 This invention relates to a current mirror circuit suitable for use with a lower voltage power supply.

### 2. Description of Related Art

Current mirror circuits have previously comprised MOS (Metal Oxide semiconductor) transistor and used with various semiconductor circuits. Figure 1 illustrates static characteristics of an NMOS transistor. The horizontal axis indicates the drain source voltage  $V_{ds}$  applied to an NMOS transistor and the vertical axis indicates the drain current  $I_d$ . The relation between  $I_d$  and  $V_{ds}$  is shown as the gate source voltage  $V_{gs}$  changes. The dotted line in Figure 1 represents a boundary of two regions that exist between  $I_d$  and  $V_{ds}$ . One region is on the left side of the dotted line is called the triode region, where  $I_d$  is represented by equation I.

20 When  $(V_{gs}-V_t) > V_{ds}$ ,

$$I_d = \beta [(V_{gs}-V_t) V_{ds} - 1/2 V_{ds}^2] \quad (I)$$

Where,  $V_t$  is threshold voltage of the MOS transistor.

The other region is on the right side of the dotted line and is called the pentode region, where  $I_d$  is represented by equation II.

25 When  $(V_{gs}-V_t) < V_{ds}$ ,

$$I_d = 1/2 \beta (V_{gs} - V_t)^2 \quad (II)$$

The dotted line by which divides these two regions is represented by equation III.

$$V_{gs} - V_t = V_{ds} \quad (III)$$

Moreover, when the conditions of equation IV occur, the NMOS transistor hardly allows  
5 current to flow.

$$V_{gs} < V_t \quad (IV)$$

A similar relationship also occurs in a PMOS transistor. Figure 2 shows a circuit where the two NMOS transistors M0 and M1 are connected, where the length of the gate and the width of the channel of both NMOS transistors M0 and M1 are equal.

10 Because the gate terminal and the drain terminal are short-circuited, the NMOS transistor M0 operates within the range of the pentode region regardless of the current flow of constant current source 101. The gate-source voltage of NMOS transistor M1 is equal to the voltage between the gate and the source of M0. Therefore, when the drain-source voltage is sufficiently high, NMOS transistor M1 operates within the range of the pentode region. This  
15 circuit is called a current mirror circuit because it is used to make the drain current of NMOS transistor M1 equal to the drain current of NMOS transistor M0.

In this current mirror circuit of related art, the current flowing in NMOS transistor M1 decreases when drain-source voltage of the transistor M1 decreases, and the transistor M1 begins to operate in triode region. As a result, the current value that flows in NMOS  
20 transistor M0 differs from that of NMOS transistor M1, and the current mirroring deteriorates.

Recently, semiconductor circuits have been required to operate on lower supply voltages. When current mirror circuits such as the one shown in Figure 2 operate on a lower supply voltage, the drain-source voltage of the NMOS transistor M1 drops and the operation margin  
25 of the current mirror decrease.

In the pentode region,

$$V_{gs} - V_t < V_{ds} \quad (V)$$

Then, it is possible to avoid this problem by lowering the threshold voltage of  $V_t$  for M0 and M1. However, the circuits having transistors which have a lowered threshold voltage are excessively costly to manufacture.

Moreover, the drain current of the pentode region is shown more accurately by the next  
5 expression.

When  $(V_{gs} - V_t < V_{ds})$ ,

$$I_d = 1/2 \beta (V_{gs} - V_t)^2 (1 + \lambda V_{ds}) \quad (VI)$$

where  $\lambda$  is a fitting parameter.

Even if NMOS transistor M1 operates in the pentode region, an accurate current mirroring  
10 cannot be obtained because the drain current of M1 has dependency on the drain-source voltage. To address this problem the circuit shown in Figure 3 has been proposed. NMOS transistors are placed in series in order to suppress changes of the drain voltage of transistor M11, which mirrors the current. Decreasing operation margin associated with lower supply  
15 voltages has occurred since connecting a compensation means such as transistor M11 to a mirror current in series and this technique runs counter to the trend of using lower voltages for semiconductor circuits.

## SUMMARY OF THE INVENTION

One object of this present invention is to solve the above-mentioned problems of the prior art by providing a current mirror circuit that can increase the lower supply voltage operation  
20 margin of the current mirror operation, thereby obtaining an excellent current mirror circuit, even with a low-voltage power supply, and alleviating the drain-source dependency of the mirror current.

According to one aspect of the present invention, a circuit that provides an excellent mirror current that does not deteriorate, even when the power source becomes lower supply voltage.  
25 In a presently preferred embodiment, A mirror current flows in a first MOS transistor when a constant current flows in the MOS transistor from a current source. An operational unit outputs the difference between voltage  $V_{g1}$  of the gate of the MOS transistor and voltage  $V_{d1}$  of the drain, and applies this difference to the gate of a second MOS transistor. When the

power-supply voltage of this circuit becomes lower and the absolute value of  $V_{d1}$  decreases, the MOS transistors enter the triode region, and the mirror current decreases. When the absolute value of  $V_{d1}$  decreases, because the difference between  $V_{g1}$  and  $V_{d1}$  becomes larger, the drain current of the second MOS transistor increases, and the amount by which the mirror current decreases is counterbalanced.

## BRIEF DESCRIPTION OF DRAWINGS

Figure 1 illustrates the static characteristics of plotting the drain current against the drain-source voltage of the NMOS transistor.

Figure 2 is a circuit diagram showing an example of a current mirror circuit of related art

10 Figure 3 is a circuit diagram showing another example of a current mirror circuit of related art.

Figure 4 is a circuit diagram of a first embodiment of a current mirror circuit of the present invention.

15 Figure 5 is a plot of the relationship between the drain current and the voltage drain of the NMOS transistor.

Figure 6 is a circuit diagram of a second embodiment of a current mirror circuit of the present invention.

Figure 7 is a circuit diagram of a third embodiment of a current mirror circuit of the present invention.

20 Figure 8 is a circuit diagram of a fourth embodiment of a current mirror circuit of the present invention.

Figure 9 is a circuit diagram of a fifth embodiment of a current mirror circuit of the present invention.

25 Figure 10 is a circuit diagram of a sixth embodiment of a current mirror circuit of the present invention.

Figure 11 is a circuit diagram of a seventh embodiment of a current mirror circuit of the present invention.

Figure 12 is a circuit diagram of an eighth embodiment of a current mirror circuit of the present invention.

Figure 13 is a circuit diagram of a ninth embodiment of a current mirror circuit of the present invention.

5 Figure 14 is a circuit diagram of a tenth embodiment of a current mirror circuit of the present invention.

Figure 15 is a circuit a circuit diagram of an eleventh embodiment of a current source circuit of the present invention.

10 Figure 16 is a circuit diagram of a twelfth embodiment of a current source circuit of the present invention.

Figure 17 is a circuit diagram of a thirteenth embodiment of a current source circuit of the present invention.

Figure 18 is a circuit diagram of a fourteenth embodiment of a current source circuit of the present invention.

## 15 DETAILED DESCRIPTION OF EMBODIMENTS

Various embodiments of the present invention will be described with reference to the accompanying drawings. It is to be noted that same or similar reference numerals are applied to the same or similar parts and elements throughout the drawings, and the description of the same or similar parts and elements will be omitted or simplified.

20 Figure 4 is a circuit diagram according to a first embodiment of a current mirror circuit of the present invention. The current mirror circuit includes NMOS transistors 111 and 112. The current mirror circuit further includes a compensation circuit to improve the effects of the current mirror circuit. The compensation circuit includes a subtracter 114 and an NMOS transistor 113. The result of the subtracter 114 is input to the gate of NMOS transistor 113.

25 The subtracter 114 is a circuit that outputs the voltage difference between two input signals to the output terminal. The subtracter 114 includes an operational unit 141 and a plurality of resistors R ( $R_1$ - $R_4$ ). The voltage  $V_{g1}$  of the gates of the NMOS transistors 111 and 112, as well as the voltage  $V_{d1}$  of the drain of the NMOS transistor 112 are input to the subtracter 114,

and the subtracter 114 subtracts  $V_{d1}$  from  $V_{g1}$ . The result  $(V_{g1} - V_{d1})$  is output to the gate of the NMOS transistor 113. In comparison to the on-resistance regarding the operating point of the transistor 112 and the transistor 113, the resistance values of the four resistors  $R_1$  to  $R_4$  are made sufficiently large enough to restrain  $V_{g1}$  and  $V_{d1}$  from the fluctuations.

- 5 The NMOS transistor 111 operates in the pentode region because the drain and the gate are connected, and current  $I$  generated from the constant-current source 115 flows through the drain and the source of NMOS transistor 111. Here, suppose the drain-source voltage  $V_{d1}$  of NMOS transistor 112 is sufficiently high so that NMOS transistor 112 is operating in the pentode region. The gate-source voltage  $V_{g1}$  of NMOS transistor 112 is the same as the  
 10 NMOS transistor 111, and therefore the current  $I$  is the same as the current between the drain and the source of NMOS transistor 112. The operational unit 141 subtracts  $(V_{g1} - V_{d1})$ , and applies the result to the gate of the NMOS transistor 113. However, when  $(V_{g1} - V_{d1})$  becomes negative, 0V is acceptable as the gate voltage of NMOS transistor 113.

- When drain-source voltage  $V_{d1}$  decreases because the circuit is operating with a lower  
 15 supply voltage, NMOS transistor 112 operates in the triode region, and the mirror current that flows in NMOS transistor 112 decreases. However, when  $V_{d1}$  decreases, the value of  $V_{g1} - V_{d1}$  increases and the current that flows in NMOS transistor 113 increases. This replenishes the decrease of the mirror current that flows in NMOS transistor 112 and makes sum of the current that flows in transistors 112 and 113 almost uniform. As a result, the mirror current  
 20 operation region will extend even when the circuit is operating with a lower supply voltage.

The following is a quantitative explanation of the above-mentioned operation.

The drain current of NMOS transistor 112 is represented as follows:

If  $V_{g1} < V_t$ , then  $I_d = 0$

If  $V_{d1} < (V_{g1} - V_t)$ , then  $I_d = \beta [(V_{g1} - V_t) V_{d1} - 1/2 V_{d1}^2]$

- 25 If  $V_{d1} > (V_{g1} - V_t)$ , then  $I_d = 1/2 \beta (V_{g1} - V_t)^2$

Therefore, when the drain-source voltage is smaller than  $V_{g1} - V_t$ , the current that is mirrored decreases according to the desired value.

On the other hand, when the voltage between the gate and the source is  $V_{g1} - V_{d1}$ , the

following represents the drain current of NMOS transistor 113:

If  $V_{g1} - V_{d1} < V_t$ , then  $I_d = 0$

If  $V_{d1} < (V_{g1} - V_t)/2$ , then  $I_d = \beta [ (V_{g1} - V_d - V_t) V_{d1} - 1/2 V_{d1}^2 ]$

5 If  $V_{d1} > (V_{g1} - V_t)/2$ , then  $I_d = 1/2 \beta (V_{g1} - V_{d1} - V_t)^2 = 1/2 \beta (V_{g1} - V_t)^2 - \beta [ (V_{g1} - V_t) V_{d1} - 1/2 V_{d1}^2 ]$

The sum of the currents for NMOS transistors 112 and 113 becomes as follows:

If  $V_{g1} < V_t$ , then  $I_d = 0$

If  $V_{d1} < (V_{g1} - V_t)/2$ ,

10 then  $I_d = \beta [ (V_{g1} - V_t) V_{d1} - 1/2 V_{d1}^2 ] + \beta [ (V_{g1} - V_{d1} - V_t) V_{d1} - 1/2 V_{d1}^2 ] = \beta [ (V_{g1} - 2V_{d1} - V_t) V_{d1} - 1/2 V_{d1}^2 ]$

If  $V_{d1} > (V_{g1} - V_t)/2$ , then  $I_d = 1/2 \beta (V_{g1} - V_t)^2$

15 Therefore, if the drain-source voltage is larger than  $(V_{g1} - V_t)/2$ , the sum total of the flowing current becomes constant. Accordingly, as indicated by the line Q in Figure 5, even if during operation the drain-source voltage lowers to  $(V_{g1} - V_t)/2$ , the mirroring of the current will not deteriorate. Compared to line P of related art, the region of the current mirror expands into the low voltage region by at least  $(V_{g1} - V_t)/2$ . By adding the compensation circuit including the subtraction circuit 114 and the NMOS transistor 113, the characteristics of the current mirror are able to expand into a region with low voltage.

20 Figure 6 is a circuit diagram of a second embodiment of a current mirror circuit of the present invention. The second embodiment of Figure 6 uses similar corresponding parts as the first embodiment indicated in Figure 4, and has been appropriately abbreviated to avoid redundancy. In this embodiment, a similar result has been achieved with the circuit layout as the first embodiment. The circuit in this embodiment includes PMOS transistors 121, 122 and 123, which have the opposite channel type as the NMOS transistor of the first  
25 embodiment.

Figure 7 is a circuit diagram of a third embodiment of a current mirror circuit of the present invention. The third embodiment of Figure 7 uses similar corresponding parts as the first

embodiment indicated in Figure 4, but has been appropriately abbreviated. In this embodiment, the current mirror circuit includes NMOS transistors 111 and 112. Connected to the current mirror circuit in multiple stages are a plurality NMOS transistors 113<sub>1</sub>, 113<sub>2</sub>, . . . , 113<sub>(n-1)</sub> and subtracters 141<sub>1</sub>, 141<sub>2</sub>, . . . , 141<sub>(n-1)</sub>. Thus,  $V_{g1}-V_{d1}$ , which is the result of subtracter 141<sub>1</sub>, is input to the gate of NMOS transistor 113<sub>1</sub> in the first stage. And  $V_{g1}-2V_{d1}$ , which is the result of the subtracter 141<sub>2</sub>, is input to the gate of NMOS transistor 113<sub>2</sub> in the second stage. And so on until the last subtracter 141<sub>(n-1)</sub>.

Therefore, the values of the arithmetic series of  $V_{g1} - V_{d1}$  to  $V_{g1} - (n-1) V_{d1}$  are applied to each NMOS transistors 113<sub>1</sub>, 113<sub>2</sub>, . . . , 113<sub>(n-1)</sub>. In other word, voltages of the arithmetic series of  $a_k$  are applied to the gate-source of the NMOS compensation transistor respectively. where  $a_k$  is the arithmetic series equal to  $V_{g1} - kV_{d1}$  ( $k=1, 2, \dots, n-1$ ),  $V_{d1}$  is the drain-source voltage of the second transistor,  $V_{g1}$  is the gate-source voltage of the second transistor, and  $n$  is the number of the NMOS transistors of the compensation circuit.

As a result, each stage of the compensation circuit operates in a similar way as the compensation circuit in Figure 4. In this embodiment of the present invention, the sum of the current of sources of NMOS transistors 113<sub>1</sub>, 113<sub>2</sub>, . . . , 113<sub>(n-1)</sub> and the current source of NMOS transistor 112 come from the mirror current of NMOS transistor 112. Moreover, it is possible to expand the current mirror characteristics to an operation with a low voltage to a greater extent than that of the first embodiment because the third embodiment has a compensation circuit that is connected in multiple stages. Therefore, excellent current mirror characteristics can be obtained, especially with a semiconductor circuit that is operating on a lower supply voltage.

Figure 8 is a circuit diagram of a fourth embodiment of a current mirror circuit of the present invention. The fourth embodiment of Figure 8 uses similar corresponding parts as the third embodiment indicated in Figure 7, and has been appropriately abbreviated. In the fourth embodiment, the current mirror circuit includes NMOS transistors 111, 112, and a compensation circuit. The compensation circuit includes a plurality of NMOS transistors 113<sub>1</sub>, 113<sub>2</sub>, etc. and subtracters 151<sub>1</sub>, 151<sub>2</sub>, etc. Connected to the current mirror circuit in multiple stages is the plurality of NMOS transistors 113<sub>1</sub>, 113<sub>2</sub>, etc., and subtracters 151<sub>1</sub>, 151<sub>2</sub>, etc. The subtracters 151<sub>1</sub>, 151<sub>2</sub>, etc., input and subtract the drain voltage and the gate voltage of NMOS transistor 112. That is, the subtracter outputs  $V_{g1}-V_{d1}$  and the result of this



subtraction is input to the gate of NMOS transistor 113<sub>1</sub>. And subtracter 151<sub>2</sub> outputs  $V_{g1} - 2V_{d1}$ , and the result of this subtraction is input to the gate of NMOS transistor 113<sub>2</sub>. A similar operation occurs as that shown in Figure 7. As a result, an excellent current-mirror operation can be obtained, even when the semiconductor circuit is used under conditions of  
5 lower supply voltage.

Moreover, in the fourth embodiment, similar to the third embodiment as shown in Figure 7, for the individual subtracters 151<sub>1</sub>, 151<sub>2</sub>, etc., the operation does not occur by using the operation result of the subtracter of the previous stage. Therefore, even if the compensation circuit is connected in multiple stages, the speed of the response does not worsen even with  
10 lower supply voltage.

Figure 9 is a circuit diagram of a fifth embodiment of a current mirror circuit of the present invention. The current mirror circuit includes transistors 111, 112, and a compensation circuit. The compensation circuit includes a PMOS transistor 116 and a level converter 117. Current is supplied to the drain of NMOS transistor 112 through PMOS transistor 116. The  
15 bias voltage is applied to the gate-drain of PMOS transistor 116 through the level converter 117.

The gate-drain voltage shown as monotonous decrease function of drain-source voltage is applied to the gate of PMOS transistor 116. Then, the bias voltage applied to the gate of the PMOS transistor 116 comes into decreasing as increasing in the voltage  $V_{d1}$  of the drain of  
20 the NMOS transistor 112. Then the current in the PMOS transistor 116 increase, the current in the NMOS transistor 112 comes into decreasing. Then, though drain-source voltage  $V_{d1}$  increases, the mirror current is constantly maintained.

Therefore, In this embodiment, adding the PMOS transistor 116 and the level converter 117 to the NMOS transistor 112, the drain-source voltage dependency of the mirror current in the  
25 pentode region of NMOS transistor 112 can be alleviated.

Figure 10 is a circuit diagram of a sixth embodiment of a current mirror circuit of the present invention. The sixth embodiment of Figure 10 uses similar corresponding parts as the fifth embodiment illustrated in Figure 9, and has been appropriately abbreviated. The current mirror circuit includes PMOS transistors 121, 122, and a compensation circuit. The  
30 compensation circuit includes an NMOS transistor 124, and a level converter 117. The

NMOS transistor 124 is connected to the drain of the PMOS transistor 122. The mirror current is almost held at a fixed value because the gate of the NMOS transistor 124 is connected to the source through the level converter 117 that is a monoaddition function for the absolute value of the source-drain voltage. Therefore, the gate of the NMOS transistor  
5 124 constantly maintains the mirror current that flows from the PMOS transistor 122. This sixth embodiment can also alleviate the dependency of the drain-source voltage on the mirror current in the pentode region of the PMOS transistor 122.

Figure 11 is a circuit diagram of a seventh embodiment of a current mirror circuit of the present invention. The seventh embodiment of Figure 11 uses similar corresponding parts as  
10 the fifth embodiment illustrated in Figure 9 and has been appropriately abbreviated. The current mirror circuit includes NMOS transistors 111, 112, a PMOS transistor 116, and a level converter 117. The drain of NMOS transistor 111 is connected to the PMOS transistor 116, and current source 115 is connected to the drain of the NMOS transistor 111. Moreover, the gate of the PMOS transistor 116 is connected to the drain of NMOS transistor 112 to  
15 supply a bias voltage through the level converter 117 which has monotonous increase function.

The gate-source voltage expressed by a monotonous increase function of drain-source voltage is applied to the gate of PMOS transistor 116. Then, the bias voltage applied to the gate of the PMOS transistor 116 comes into increasing as increasing in the voltage  $V_{d1}$  of the  
20 drain of the NMOS transistor 112, so that current added to the current from the current source 115 decreases. Therefore, though mirror current in the NMOS transistor 112 decreases, the increasing of mirror current by increasing voltage  $V_{d1}$  is offset by the decreasing mirror current in the NMOS transistor 112. Then the mirror current is constantly maintained.

Therefore, in the seventh embodiment, the drain-source voltage dependency of the mirror  
25 current in the pentode region of PMOS transistor 116 can be alleviated.

Figure 12 is a circuit diagram of an eighth embodiment of a current mirror circuit of the present invention. The eighth embodiment of Figure 12 uses similar corresponding parts as the eighth embodiment illustrated in Figure 10, but has been appropriately abbreviated. In the eighth embodiment, PMOS transistors are employed in the circuit. The current mirror  
30 circuit includes PMOS transistors 121, 122, an NMOS transistor 124, and a level converter

117. The NMOS transistor 124 is connected to the drain of the PMOS transistor 121. The gate of the NMOS transistor 124 is connected to the source of the PMOS transistor 122 through level converter 117 which has monotonous decrease function of the absolute value of the drain-source voltage. When a change occurs in the drain voltage of the PMOS transistor 122, the NMOS transistor 124 causes the drain current of the PMOS transistor 121 to change. This allows the mirror current of the PMOS transistor 122 to remain stable and constant. Therefore the eighth embodiment alleviates the drain-source voltage dependency of the mirror current in the pentode region of the PMOS transistor 122.

Figure 13 is a circuit diagram of a ninth embodiment of a current mirror circuit of the present invention. The current mirror circuit includes NMOS transistors 111 and 118, NMOS transistors 112 and 119, which are respectively connected in series, and a compensation circuit.

The compensation circuit includes subtracter 133, and 134, and NMOS transistor 131, and 132. The subtracter 133 is connected to the drain of the NMOS transistor 112 as input. Also the subtracter 133 is connected to the gate of the NMOS transistor 131 as output. The subtracter 134 is connected to the drain of the NMOS transistor 119 as input. Also the subtracter 134 is connected to the gate of the NMOS transistor 132 as output. The drain of the NMOS transistor 131 is connected to the drain of the NMOS transistor 112. And the source of the NMOS transistor 131 is connected to the drain of the NMOS transistor 132. The source of the NMOS transistor 132 is connected to the ground voltage. That is, the NMOS transistor 131 and NMOS transistor 132 is connected in series.

In this embodiment, subtracter 133 subtracts drain-source voltage  $V_{d1}$  from gate-source voltage  $V_{g1}$  of the NMOS transistor 112, and applies the result to the gate-source of the NMOS transistor 131. The subtracter 134 subtracts drain-source voltage  $V_{d2}$  from gate-source voltage  $V_{g2}$  of the NMOS transistor 119, and applies the result to the gate-source of NMOS transistor 132.

Owing to the compensation circuit, the decrease of the mirror current of each stage including the NMOS transistors 111 and 112 as well as the NMOS transistor 118 and 119 because of the lower supply voltage is offset by the current that flows in the NMOS transistors 131 and 132. As a result, the stabilized sum of the drain currents that flow through

the NMOS transistor 119 and 132 makes the mirroring not deteriorate in spite of lower supply voltage,. And the region of the mirror current expands to the low-voltage region even more than related art.

5 In the ninth embodiment, The mirror current characteristics can be expanded to the low-voltage region to employ the compensation circuit including subtracters 133, and 134, and NMOS transistors 131, and 132. Therefore, even with the lower supply voltage of a semiconductor circuit, the good characteristics of a mirror current can be obtained. Moreover, the current mirror circuit in series can ease the dependency of the drain-source voltage of the mirror current in the pentode region.

10 Though in the ninth embodiment as illustrated in Figure 13, the NMOS transistors 111 and 112 as well as the NMOS transistor 118 and 119 were made into a two-stage series circuit. Performance can also be improved in case of the three or more series stages are used. More performance can be achieved in case of a compensation circuit including NMOS transistor 131, subtracter 133, NMOS transistor 132, and subtracter 134 has a plurality of  
15 NMOS transistors and subtracters connected as illustrated in Figures 7 and 8.

Figure 14 is a circuit diagram of a tenth embodiment of a current mirror circuit of the present invention. The current mirror circuit includes PMOS transistors 121 and 122, PMOS transistors 125 and 126, which are respectively connected in series, and a compensation circuit.

20 The compensation circuit includes PMOS transistor 127 and subtracter 129 as well as PMOS transistor 128 and subtracter 130. The operation of the tenth embodiment is similar to that of the eighth embodiment, with the similar results. In the tenth embodiment as well performance can be improved with a structure that connects a plurality of compensation circuits or multistage current mirror circuits. An excellent mirror current can be obtained by  
25 increasing the lower supply voltage operation margin of the current-mirror operation, even with a low-voltage power supply. Moreover, the dependency of drain-source voltage of the mirror current is alleviated.

A current mirror circuit includes a circuit that references a current and another circuit that replicates the referenced current. Therefore, the concept of the present invention can also be  
30 used in the following ways to make a current source circuit.

Figure 15 is a circuit diagram of an eleventh embodiment of a current source circuit of the present invention. In this embodiment,  $n$  NMOS compensation transistors  $215_1, 215_2, \dots, 215_n$  ( $n$  is the number of NMOS) are connected in parallel with a current source, these transistors include a NMOS transistor  $215_0$  which applied voltage  $V_{g1}$  is applied to the gate-source, also applied voltage  $V_{d1}$  is applied to the drain-source. An applied voltage  $(V_{g1}-V_{d1})$  is applied to the gate of NMOS transistor  $215_1$ . An applied voltage  $(V_{g1}-2V_{d1})$  is applied to the gate of NMOS transistor  $215_2$ . Similarly, an applied voltage  $(V_{g1}-nV_{d1})$  is applied to the gate of NMOS transistor  $215_n$ . The voltages that apply to these NMOS transistors can express as an arithmetic series. The first term of the arithmetic series is  $V_{g1}-V_{d1}$ , the last term is  $V_{d1}-nV_{d1}$ , and difference between each term is  $-V_{d1}$ .

When voltage  $V_{d1}$  decreases, the NMOS transistor  $215_0$  comes to operate in the triode region and the current that flows in the NMOS transistor  $215_0$  decreases. When the voltage  $V_{d1}$  decreases, then the voltages  $(V_{g1}-V_{d1}), (V_{g1}-2V_{d1}), \dots, (V_{g1}-nV_{d1})$  increase respectively. And also the current that flows through NMOS transistors  $215_1, 215_2, \dots, 215_n$  increases respectively. Because of the compensation of the decrease, the sum total of the current which flows through NMOS transistors  $215_0, 215_1, 215_2, \dots, 215_n$  can nearly be made constant. Therefore, the constant current region becomes extended under conditions of lower supply voltage, and the characteristics of constant-current source can be improved even if the semiconductor circuit operates in a low supply voltage.

Figure 16 is a circuit diagram of an eleventh embodiment of a current source circuit of the present invention. In this embodiment, PMOS transistors are employed. The current source made from PMOS transistor  $216_0$  is connected in parallel with the compensation PMOS transistors  $216_1, 216_2, \dots, 216_n$ . Therefore, the eleventh embodiment has a similar operation and result as the tenth embodiment.

Figure 17 is a circuit diagram of a twelfth embodiment of a current source circuit of the present invention. The twelfth embodiment includes a power source of  $n$  NMOS transistors  $217_1, 217_2, \dots, 217_n$  connected in series and a compensation circuit having  $n$  compensation NMOS transistors  $219_1, 219_2, \dots, 219_n$  connected in series. Between the gate and the source for each compensation NMOS transistor  $219_1, 219_2, \dots, 219_n$ , the voltage  $(V_{gi}-V_{di})$  is applied, wherein  $V_{di}$  ( $i = 1$  to  $n$ ) is the drain-source voltage and  $V_{gi}$  ( $i = 1$  to  $n$ ) is the gate-source voltage of the transistors  $217_1, 217_2, \dots, 217_n$ , which form the power source.

Moreover, the drain of compensation NMOS transistor 219<sub>n</sub> and NMOS transistor 217<sub>n</sub>, which forms the current source, are connected together respectively. The sources of NMOS transistor 217<sub>1</sub> and compensation NMOS transistor 219<sub>1</sub> are each connected to the ground voltage. When the circuit operates in a lower supply voltage, the transistors 217<sub>1</sub>, 217<sub>2</sub>, . . . , 217<sub>n</sub> shift from the pentode region to the triode region and the current which flows in the series circuit decreases. Then, the voltages ( $V_{gs} - V_{th}$ ) applying to the gate-source of compensation NMOS transistors 219<sub>1</sub>, 219<sub>2</sub>, . . . , 219<sub>n</sub> increase. And the flow of the current for the series circuit of compensation NMOS transistors 219<sub>1</sub>, 219<sub>2</sub>, . . . , 219<sub>n</sub> increases. Namely the current decreasing is supplemented, thereby nearly constantly preserving the sum total of the current in both series circuits. Therefore, in the twelfth embodiment as well, the constant current region is extended to the low-voltage region, and even with a low-voltage semiconductor, the characteristics of the constant-current source are improved. Moreover, the constant-current source of a series connection can alleviate the dependency of the drain-source voltage of the constant current of the pentode region.

Figure 18 is a circuit diagram of a thirteenth embodiment of a current source circuit of the present invention. In the thirteenth embodiment, PMOS transistors are employed. The power source is formed from PMOS transistors 218<sub>1</sub>, 218<sub>2</sub>, . . . , 218<sub>n</sub> and the corrective circuits are formed from PMOS transistors 212<sub>1</sub>, 212<sub>2</sub>, . . . , and 212<sub>n</sub>. Accordingly, the operation and result of the thirteenth embodiment is similar to that of the twelfth embodiment.

Various modifications will become possible for those skilled in the art after receiving the teaching of the present disclosure without departing from the scope thereof.